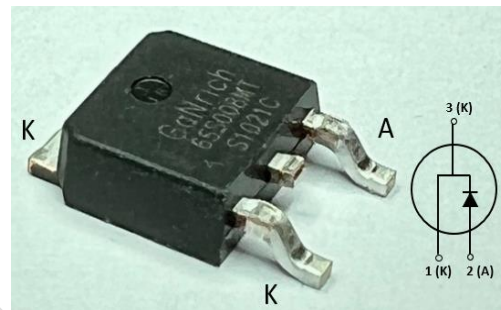


## GR-65S008MT – SiC 650V 8A Schottky Barrier Diode

### Features

- 650-Volt Schottky Rectifier
- High-Frequency Operation
- Temperature-Independent Switching Behavior
- Extremely Fast Switching
- Positive Temperature Coefficient on VF
- Low capacitive charge
- Product Summary

VR	650	V
IF(T <sub>j</sub> =175°C)	8	A
Q <sub>c</sub>	18	nC



**GR-65S008MT, DPAK TO252**

### Potential Applications

- Boost Diodes in PFC or DC/DC stages
- Switch Mode Power Supplies (SMPS)
- AC/DC Converters
- Motor Drives

### Product Validation

- Qualified for industrial applications according to the relevant tests of JEDEC22

Production Name	Package
GR-65S008MT	DPAK- TO252

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## 1- Electrical Characteristics and Parameters

◆ **Table 1 Absolute Maximum Ratings** ( $T_j = 25^\circ\text{C}$  unless otherwise noted)

Symbol	Parameter	Value	Unit
VRRM	Repetitive Peak Reverse Voltage	650	V
VRSM	Surge Peak Reverse Voltage	650	V
$I_F$	Continuous Forward Current@ $T_C < 150^\circ\text{C}$	8	A
$I_{FM}$	Non-Repetitive Peak Forward Surge Current $T_C=25^\circ\text{C}$ , $t_p=10\text{ms}$ , Half Sine Wave, $D=0.3$	40	A
$I_{FSM}$	Non-Repetitive Forward Surge Current (Half-Sine Pulse) $T_C= 25^\circ\text{C}$ , $t_p =10\text{ ms}$ , $D=0.3$	56	A
$T_j$	Operating Junction and Storage Temperature Range	-55~175	$^\circ\text{C}$
$P_{tot}$	Total dissipation at $T_C = 25^\circ\text{C}$ Operation	107	W

◆ **Table 2 Thermal Characteristics**

Symbol	Parameter	Value	Unit
$R_{thj-amb}$	(*)Thermal resistance junction-ambient	1.32	$^\circ\text{C}/\text{W}$

(\*) When Mounted on 1 inch<sup>2</sup> FR-4 board, 2 oz of Cu and  $t = 10\text{ sec}$ .

◆ **Table 3 Electrical Characteristics** ( $T_j = 25^\circ\text{C}$  unless otherwise noted)

### Static Characteristics

Symbol	Parameter	Test Conditions	Values			Unit
			Min.	Typ.	Max.	
VR	DC Blocking Voltage	IR=100uA	650	-	-	V
VF	Forward Voltage	IF=8A, $T_j = 25^\circ\text{C}$		1.4	1.8	V
		IF=8A, $T_j = 175^\circ\text{C}$		1.8	2.4	V
IR	Reverse Current	VR=650V, $T_j = 25^\circ\text{C}$		0.9	50	uA
		VR=650V, $T_j = 175^\circ\text{C}$		15	150	uA

## AC Characteristics

Symbol	Parameter	Test Conditions	Values			Unit
			Min.	Typ.	Max.	
C <sub>j</sub>	Total Capacitance	VR=0.1V, f=1MHz		320		pF
		VR=100V, f=1MHz		45		pF
		VR=400V, f=1MHz		30		pF
Q <sub>c</sub>	Total Capacitive Charge	VR=400V, T <sub>j</sub> =25°C, di/dt = 200 A/μs, IF ≤IF <sub>MAX</sub>		18		nC
E <sub>c</sub>	Capacitance Stored Energy	VR=400V, T <sub>j</sub> =25°C		3.6		uJ

## 2- Typical Characteristic Curves

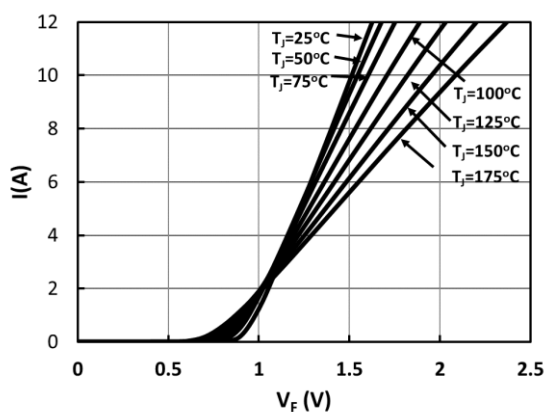


Figure 1: Typical Forward Characteristics

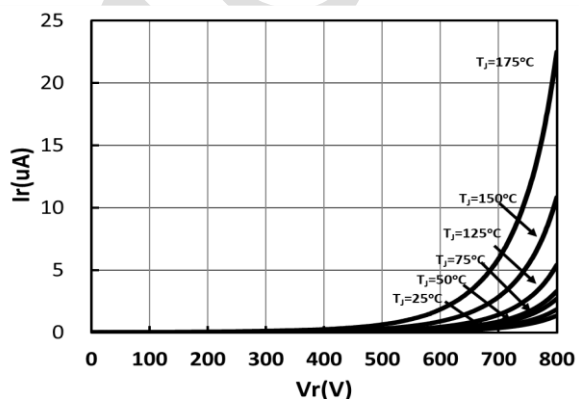


Figure 2: Typical reverse current versus reverse voltage

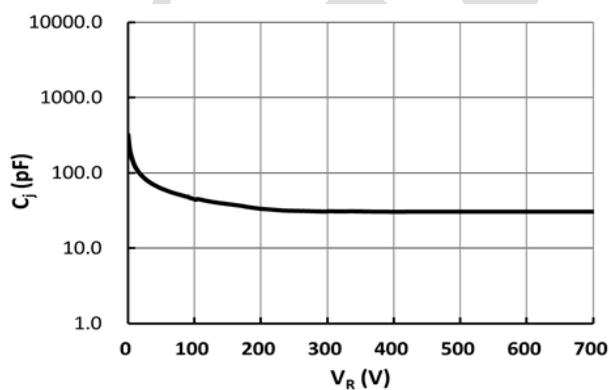


Figure 3: Junction capacitance versus reverse voltage applied (typical values)

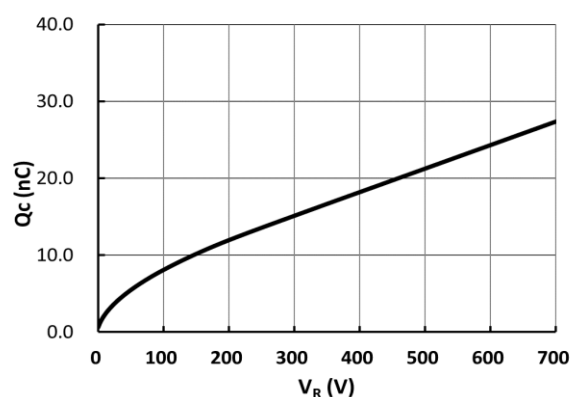


Figure 4: Total capacitive charges versus reverse voltage applied (typical values)

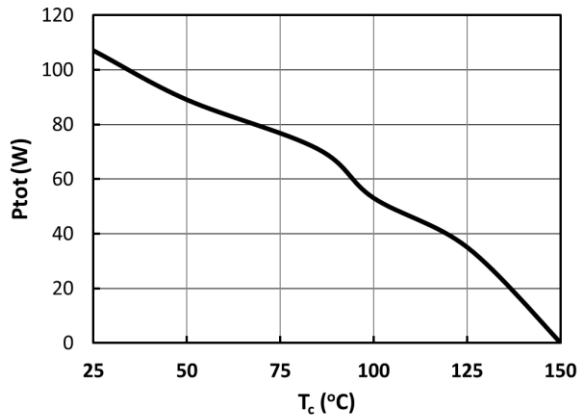


Figure 5: Power dissipation versus case temperature

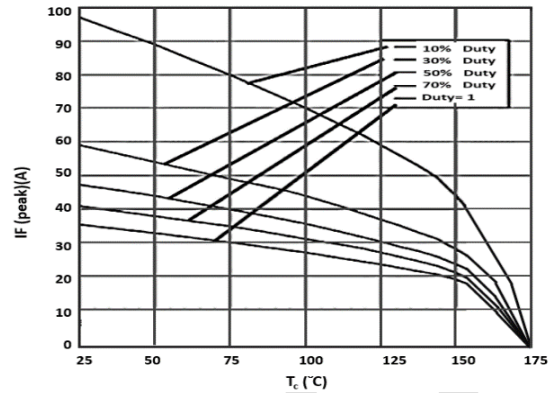


Figure 6: Peak forward current versus case temperature

### 3- Package Outline

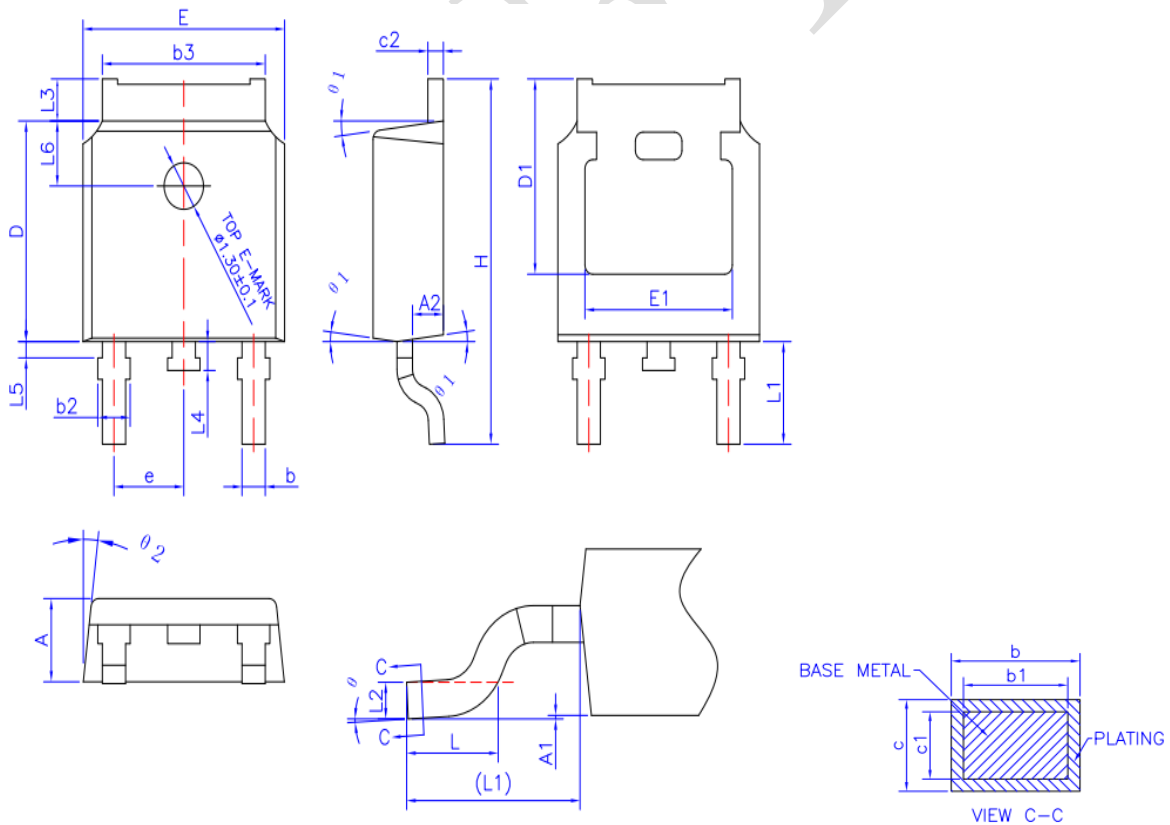


Figure 7 Package Outline of GR-65S008MT

COMMON DIMENSIONS  
(UNITS OF MEASURE =MILLIMETER)

SYMBOL	MIN	NOM	MAX
A	2.20	2.30	2.38
A1	0	---	0.10
A2	0.90	1.01	1.10
b	0.72	---	0.85
b1	0.71	0.76	0.81
b2	0.72	---	0.90
b3	5.13	5.33	5.46
c	0.47	---	0.60
c1	0.46	0.51	0.56
c2	0.47	---	0.60
D	6.00	6.10	6.20
D1	5.25	---	---
E	6.50	6.60	6.70
E1	4.70	---	---
e	2.186	2.286	2.386
H	9.80	10.10	10.40
L	1.40	1.50	1.70
L1	2.90 REF		
L2	0.508 BSC		
L3	0.90	---	1.25
L4	0.60	0.80	1.00
L5	0.15	---	0.75
L6	1.80 REF		
θ	0°	---	8°
θ1	5°	7°	9°
θ2	5°	7°	9°

Table 4 Dimension of GR-65S008MT

### GR DAPK-TO252 Footprint:

All units are in millimeters

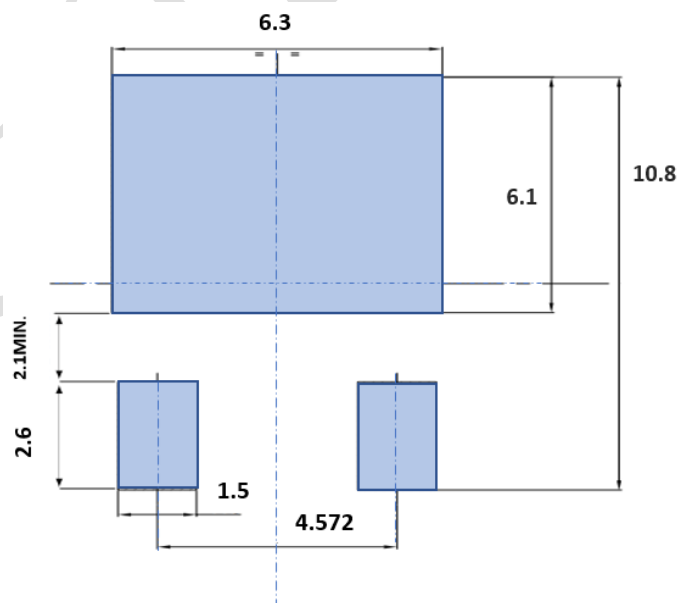


Figure 8 Recommended PCB Solder Pad

## 4- Reflow Soldering Profile

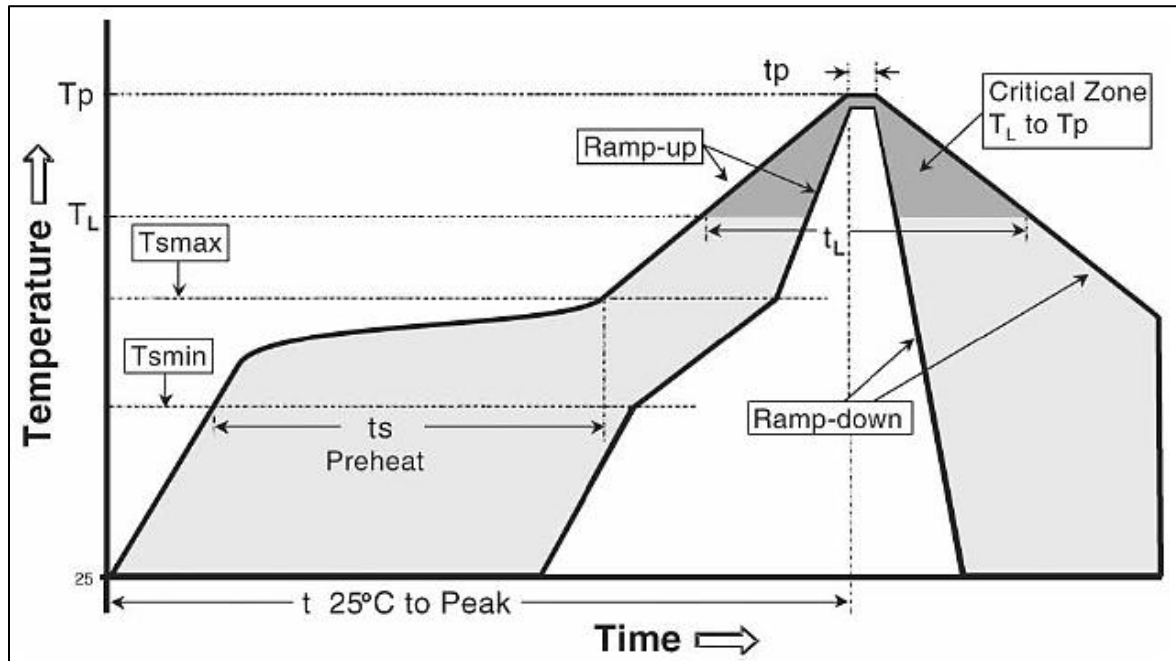


Figure 9 Recommended Reflow Soldering Condition (IPC/JEDEC J-STD-020 Revision C)

Profile Feature		Pb-Free Assembly
Average Ramp-Up Rate ( $T_{smax}$ to $T_p$ )		3 °C/second max.
Preheat	Temperature Min ( $T_{smin}$ )	150 °C
	Preheat: Temperature Max ( $T_{smax}$ )	200 °C
	Time ( $t_{smin}$ to $t_{smax}$ )	60-180 seconds
Time Maintained Above	Temperature ( $T_L$ )	217 °C
	Time ( $t_L$ )	60-150 seconds
Peak Temperature ( $T_p$ )		260 °C
Time Within 5 °C of Actual Peak Temperature ( $t_p$ )		20-40 seconds
Ramp-Down Rate		6 °C/second max.
Time 25 °C to Peak Temperature		8 minutes max.

Note: All temperatures refer to the topside of the package, measured on the package body surface.

## 5- Application Circuit

### -PFC Boost

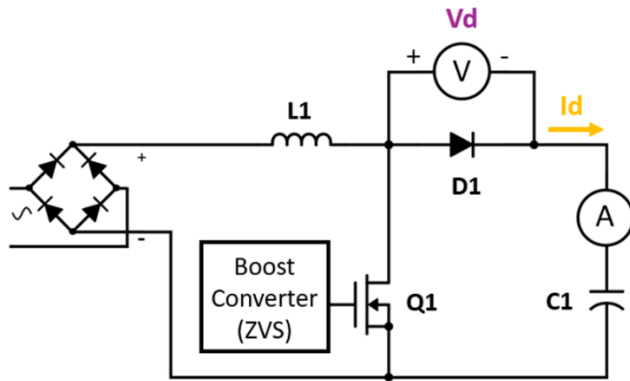


Figure 10: Diode Characteristics -Test Circuit for PFC Boost

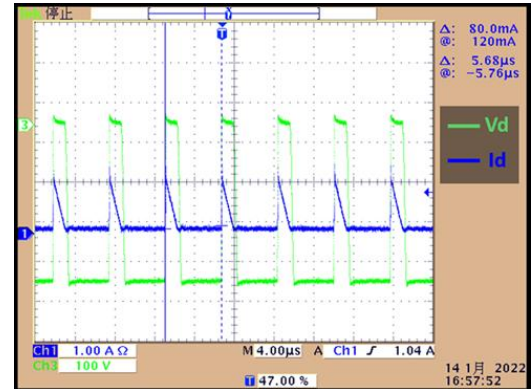


Figure 11: Test Waveform of diode for PFC Boost 150W 400V/0.375A @230Vac

### - Reverse Recovery Characteristics of Diodes

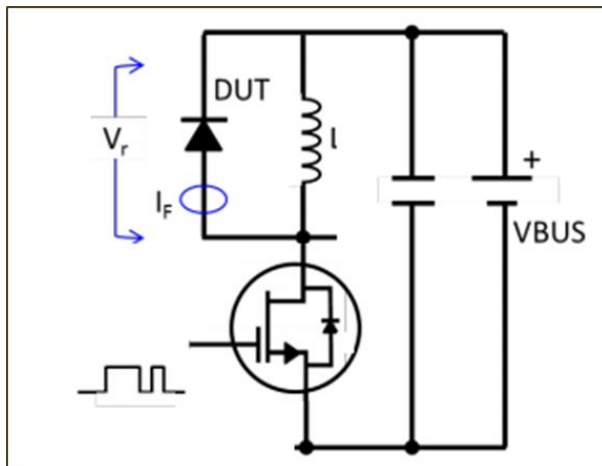


Figure 12: Test circuit for measuring reverse recovery characteristics of diodes.

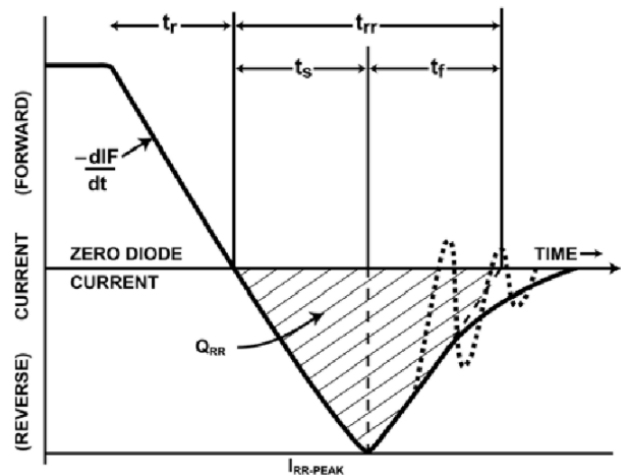
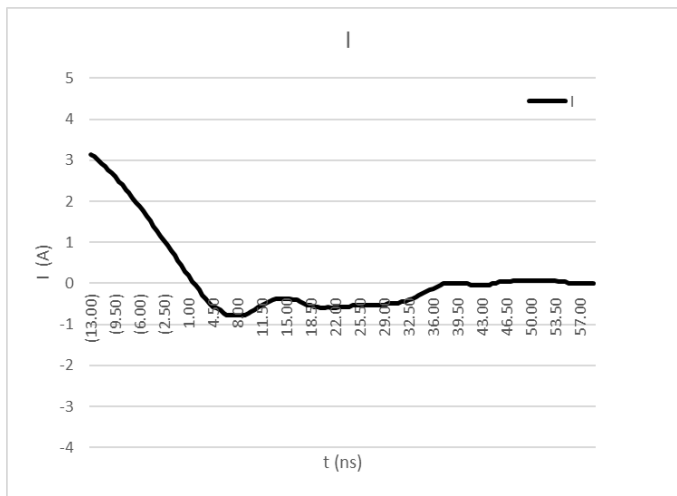


Figure 13: Definitions of the different portions of a high-voltage, power rectifier's reverse recovery current waveform





- Total capacitive charge  
 $V_R = 400 \text{ V}$ ,  $di/dt = 200 \text{ A}/\mu\text{s}$ ,  
 $I_F \leq I_F, \text{ MAX}$ ,  $T_j = 25 \text{ }^\circ\text{C}$

$$Q_c = \int_{t(I=>0 \rightarrow 0)}^{t(I=<0 \rightarrow 0)} I d(t)$$

$$= 17.36 \text{ nC} \leq 18 \text{ nC}$$

Figure 13: Test Waveform of SiC Diode  $Q_c$ ,  $T_j = 25^\circ\text{C}$

## 6- Revision History

Date	Revision	Changes
15-Dec-21	1	First issue
07-Feb-22	2	Application Circuit